

### N4421-VB Datasheet

# P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY     |                                    |                                 |                       |  |  |
|---------------------|------------------------------------|---------------------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | $R_{DS(on)}\left(\Omega\right)$    | I <sub>D</sub> (A) <sup>a</sup> | Q <sub>g</sub> (Typ.) |  |  |
| - 30                | 0.030 at V <sub>GS</sub> = - 10 V  | - 5.1                           | 5.1 nC                |  |  |
|                     | 0.042 at V <sub>GS</sub> = - 4.5 V | - 4.1                           | 5.1 nC                |  |  |

#### **FEATURES**

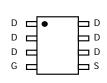
- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET

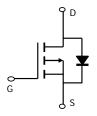
# COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

· Load Switch







| <b>ABSOLUTE MAXIMUM RATIN</b>                      | IGS T <sub>A</sub> = 25 °C,   | unless otherwise | noted  |      |  |
|--|---|------------------|--|------|--|
| Parameter  |   | Symbol           | Limit  | Unit |  |
| Drain-Source Voltage                               |   | V <sub>DS</sub>  | - 30   | V    |  |
| Gate-Source Voltage                                |   | $V_{GS}$         | ± 20   | v    |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$ | I <sub>D</sub>   | - 5.1<br>- 4.1<br>- 4.1 <sup>b, c</sup><br>- 3.3 <sup>b, c</sup> | A    |  |
| Pulsed Drain Current                               |   | I <sub>DM</sub>  | - 20   |      |  |
| Continuous Source-Drain Diode Current              | $T_C = 25 ^{\circ}C$<br>$T_A = 25 ^{\circ}C$  | Is               | - 2.5<br>- 1.67 <sup>b, c</sup>                                  |      |  |
| Maximum Power Dissipation                          | $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$ | P <sub>D</sub>   | 3.0<br>2.0<br>2.0 <sup>b, c</sup><br>1.3 <sup>b, c</sup>         | W    |  |
| Operating Junction and Storage Temperatur          | T <sub>J</sub> , T <sub>sta</sub>   | - 55 to 150      | °C   |      |  |

| THERMAL RESISTANCE RATINGS                  |              |            |         |      |        |  |
|---|--------------|------------|---------|------|--------|--|
| Parameter                                   | Symbol       | Typical    | Maximum | Unit |        |  |
| Maximum Junction-to-Ambient <sup>b, d</sup> | t ≤ 5 s      | $R_{thJA}$ | 55      | 62.5 | °C/W   |  |
| Maximum Junction-to-Foot (Drain)            | Steady State | $R_{thJF}$ | 34      | 41   | 5/ * * |  |

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C.
  b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 110 °C/W.

服务热线:400-655-8788



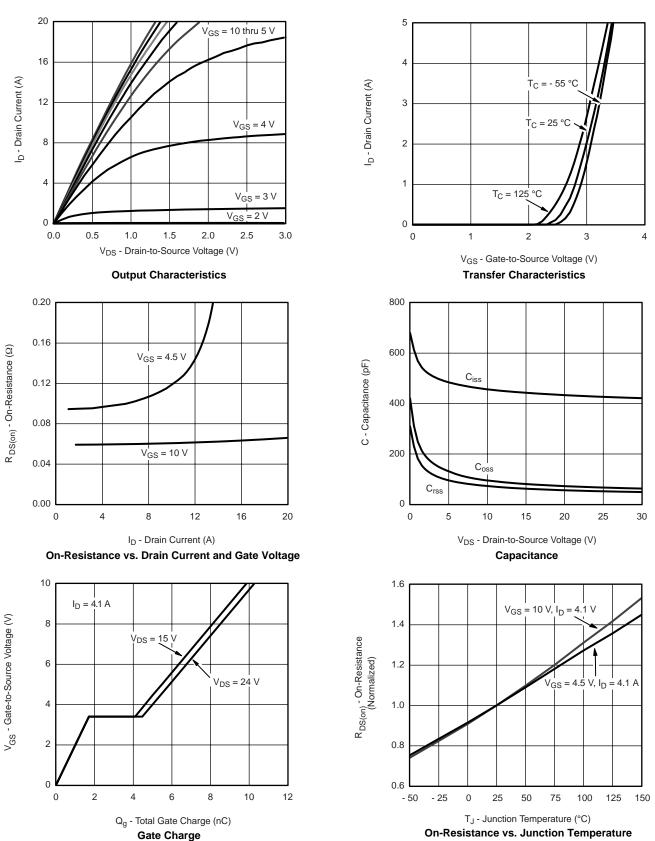
| <b>SPECIFICATIONS</b> $T_J = 25  ^{\circ}C$ , |                         |   |       |       |         |         |
|---|-------------------------|---|-------|-------|---------|---------|
| Parameter                                     | Symbol                  | Test Conditions   | Min.  | Тур.  | Max.    | Unit    |
| Static  |                         |   |       |       | ı       | T       |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>         | $V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$                                    | - 30  |       |         | V       |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$   | I <sub>D</sub> = - 250 μA   |       | - 31  |         | mV/°C   |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$ | į ,   |       | 4.5   |         | 111 V/  |
| Gate-Source Threshold Voltage                 | $V_{GS(th)}$            | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$   | - 1.0 |       | - 3.0   | V       |
| Gate-Source Leakage                           | I <sub>GSS</sub>        | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                                   |       |       | ± 100   | nA      |
| Zero Gate Voltage Drain Current               | Inco                    | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$                                      |       |       | - 1     |         |
| Zeio Gale Vollage Dialii Current              | IDSS                    | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$               |       |       | - 10 µA |         |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>      | $V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$                                   | - 20  |       |         | Α       |
|   | D                       | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 4.1 A                                  |       | 0.030 |         |         |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>     | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 1.0 A                                 |       | 0.042 |         | Ω       |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>         | V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 4.1 A                                  |       | 8     |         | S       |
| Dynamic <sup>b</sup>                          |                         |   |       |       | I.      |         |
| Input Capacitance                             | C <sub>iss</sub>        |   |       | 450   |         |         |
| Output Capacitance                            | C <sub>oss</sub>        | $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$                   |       | 80    |         | pF      |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>        |   |       | 63    |         |         |
| Total Cata Charra                             |                         | V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 4.1 A        |       | 10    | 15      | nC      |
| Total Gate Charge                             | Qg                      |   |       | 5.1   | 8       |         |
| Gate-Source Charge                            | Q <sub>gs</sub>         | V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 4.1 A       |       | 1.8   |         |         |
| Gate-Drain Charge                             | $Q_{gd}$                |   |       | 2.5   |         |         |
| Gate Resistance                               | R <sub>g</sub>          | f = 1 MHz   |       | 7     |         | Ω       |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |       | 40    | 60      |         |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD} = -15 \text{ V}, R_{L} = 4.6 \Omega$  |       | 80    | 120     | -<br>-  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong -3.3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$                |       | 20    | 30      |         |
| Fall Time                                     | t <sub>f</sub>          |   |       | 12    | 20      |         |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |       | 5     | 10      | ns<br>- |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD} = -15 \text{ V}, R_{L} = 4.6 \Omega$  |       | 13    | 20      |         |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong -3.3 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$                 |       | 20    | 30      |         |
| Fall Time                                     | t <sub>f</sub>          |   |       | 10    | 15      |         |
| Drain-Source Body Diode Characteristic        | cs                      |   |       |       |         | ı       |
| Continuous Source-Drain Diode Current         | Is                      | T <sub>C</sub> = 25 °C  |       |       | - 2.5   |         |
| Pulse Diode Forward Current <sup>a</sup>      | I <sub>SM</sub>         |   |       |       | - 20    | A       |
| Body Diode Voltage                            | V <sub>SD</sub>         | I <sub>S</sub> = - 3.3 A  |       | - 0.8 | - 1.2   | V       |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>         | <u> </u>  |       | 20    | 30      | ns      |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>         |   |       | 20    | 30      | nC      |
| Reverse Recovery Fall Time                    | t <sub>a</sub>          | $I_F = -3.3 \text{ A}, \text{ di/dt} = 100 \text{ A/µs}, T_J = 25 ^{\circ}\text{C}$ |       | 14    |         |         |
| Reverse Recovery Rise Time                    | t <sub>b</sub>          |   |       | 6     |         | ns      |

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.

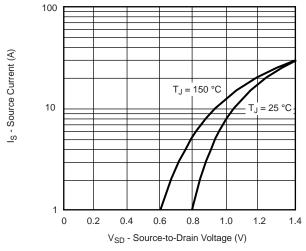
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

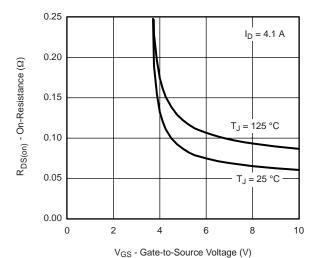
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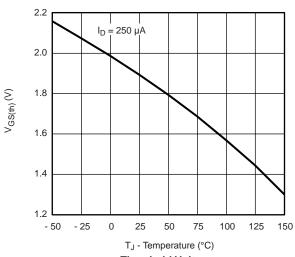


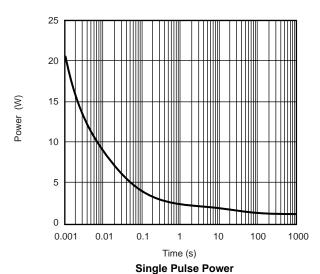




#### Source-Drain Diode Forward Voltage

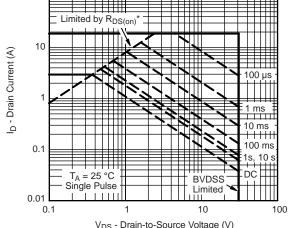






**Threshold Voltage** 

100 Limited by R<sub>DS(on)</sub>\*

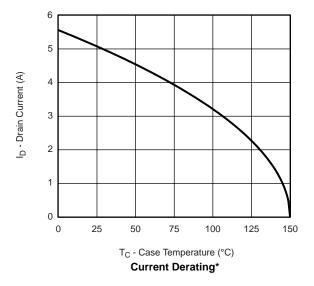


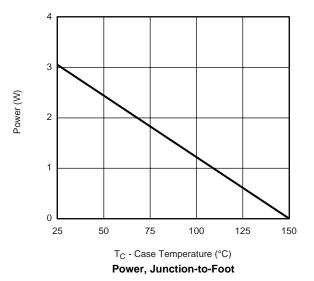
V<sub>DS</sub> - Drain-to-Source Voltage (V)

\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area



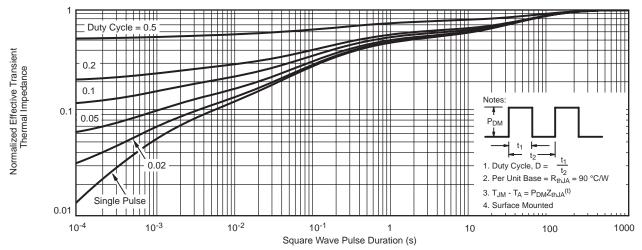




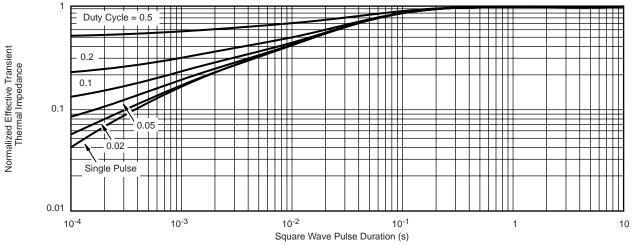
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

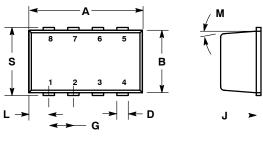


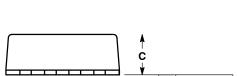
Normalized Thermal Transient Impedance, Junction-to-Foot

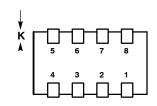


#### **PACKAGE DIMENSIONS**

**ChipFET** CASE 1206A-03 ISSUE D







#### STYLE 2:

- 2. GATE 1
- 4. GATE 2

- 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
   CONTROLLING DIMENSION: MILLIMETER.
   MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
   LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
   DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
   NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
   1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

|     | MILLIN   | METERS | INC   | INCHES |  |
|-----|----------|--------|-------|--------|--|
| DIM | MIN      | MAX    | MIN   | MAX    |  |
| Α   | 2.95     | 3.10   | 0.116 | 0.122  |  |
| В   | 1.55     | 1.70   | 0.061 | 0.067  |  |
| C   | 1.00     | 1.10   | 0.039 | 0.043  |  |
| D   | 0.25     | 0.35   | 0.010 | 0.014  |  |
| G   | 0.65 BSC |        | 0.02  | 5 BSC  |  |
| J   | 0.10     | 0.20   | 0.004 | 0.008  |  |
| K   | 0.28     | 0.42   | 0.011 | 0.017  |  |
| L   | 0.55 BSC |        | 0.02  | 2 BSC  |  |
| M   | 5° NOM   |        | 5 °   | NOM    |  |
| S   | 1.80     | 2.00   | 0.072 | 0.080  |  |



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